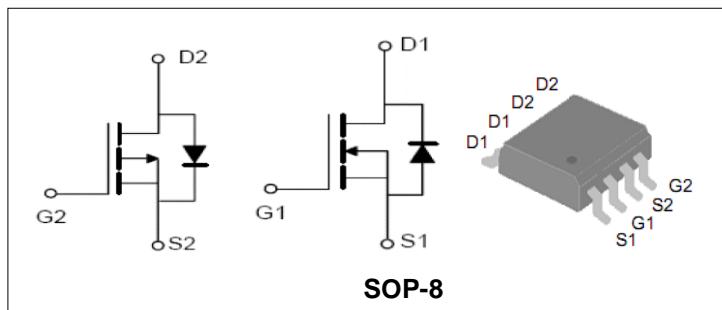


Complementary High Density Trench MOSFET
Features

- Improved dv/dt Capability, High Ruggedness.
- Maximum Junction Temperature Range (150°C)
- 100% Avalanche Tested

Applications

- PWM applications
- Load switch
- Power management



N-Channel		
BVDSS	30	V
ID	5.8	A
RDSON@VGS=10V	16	mΩ
RDSON@VGS=4.5V	23	mΩ

P-Channel		
BVDSS	-30	V
ID	-6.5	A
RDSON@VGS=-10V	25	mΩ
RDSON@VGS=-4.5V	37	mΩ

Order Information

Product	Package	Marking	Reel Size	Reel	Carton
PT4606A	SOP-8	PT4606A	13inch	3000PCS	48000PCS

Absolute Maximum Ratings

Symbol	Parameter	N-Channel	P-Channel	Unit	
Common Ratings (TC=25°C Unless Otherwise Noted)					
V _{(BR)DSS}	Drain-Source Breakdown Voltage	30	-30	V	
V _{GS}	Gate-Source Voltage	±20	±20	V	
T _J	Maximum Junction Temperature	150	150	°C	
T _{STG}	Storage Temperature Range	-55 to 150	-55 to 150	°C	
I _S	Diode Continuous Forward Current TA =25°C	5.8	-6.5	A	
Mounted on Large Heat Sink					
I _{DM}	Pulse Drain Current Tested (Silicon Limit) (Note1)	TA =25°C	20	-30	A
I _D	Continuous Drain current	TA =25°C	5.8	-6.5	A
P _D	Maximum Power Dissipation	TC =25°C	2	2	W
R _{θJA}	Thermal Resistance Junction-to-Ambient (Note2)		63.2	63.2	°C/W



Complementary High Density Trench MOSFET

N-Channel Electrical Characteristics

Symbol	Parameter	Condition	Min.	Typ.	Max.	Unit
Static Electrical Characteristics @ $T_J = 25^\circ C$ (unless otherwise stated)						
$V_{(BR)DSS}$	Drain- Source Breakdown Voltage	$V_{GS}=0V, ID=250\mu A$	30	--	--	V
I_{DSS}	Zero Gate Voltage Drain current	$V_{DS}=30V, V_{GS}=0V$	--	--	1	μA
I_{GSS}	Gate-Body Leakage Current	$V_{GS}=\pm 20V, V_{DS}=0V$	--	--	± 100	nA
$V_{GS(TH)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}, ID=250\mu A$	1	1.5	3	V
$R_{DS(ON)}$	Drain-Source On-State Resistance (Note3)	$V_{GS}=10V, ID=5.8A$	--	16	22	$m\Omega$
		$V_{GS}=4.5V, ID=5A$	--	23	25	$m\Omega$
g_{FS}	Forward Transconductance	$V_{DS}=5V, ID=5A$	--	6	--	S
Dynamic Electrical Characteristics @ $T_J = 25^\circ C$ (unless otherwise stated) (Note4)						
C_{iss}	Input Capacitance	$V_{DS}= 15V,$ $V_{GS}=0V,$ $F=1MHz$	--	458	--	pF
C_{oss}	Output Capacitance		--	79	--	pF
C_{rss}	Reverse Transfer Capacitance		--	63	--	pF
Q_g	Total Gate Charge	$V_{DS}= 10V,$ $ID= 1A,$ $V_{GS}= 10V$	--	7.4	--	nC
Q_{gs}	Gate-Source Charge		--	1.7	--	nC
Q_{gd}	Gate-Drain Charge		--	1.3	--	nC
Switching Characteristics (Note4)						
$t_{d(on)}$	Turn-on Delay Time	$V_{DD}= 15V,$ $RL=15\Omega,$ $ID=1A, V_{GEN}=10V,$ $RG=6\Omega$	--	8	--	nS
t_r	Turn-on Rise Time		--	11.2	--	nS
$t_{d(off)}$	Turn-off Delay Time		--	17.2	--	nS
t_f	Turn-off Fall Time		--	7.54	--	nS
Source- Drain Diode Characteristics@ $T_J = 25^\circ C$ (unless otherwise stated)						
V_{SD}	Forward on voltage (Note3)	$IS=2.3A, V_{GS}=0V$	--	--	1.2	V



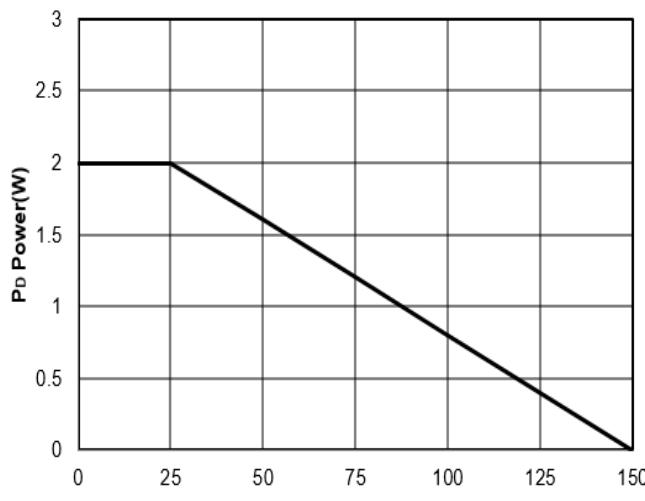
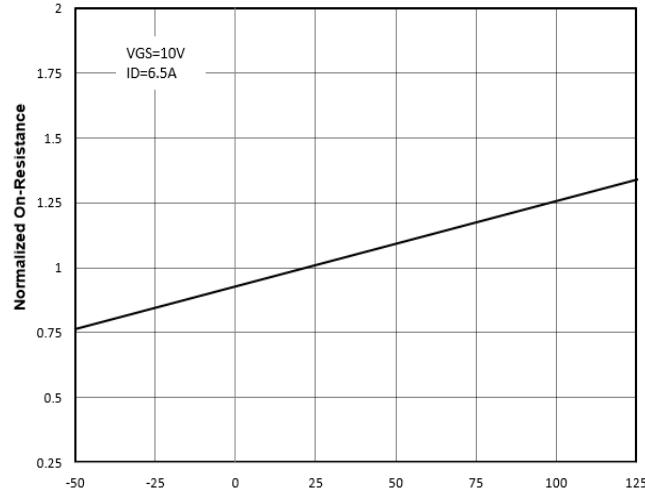
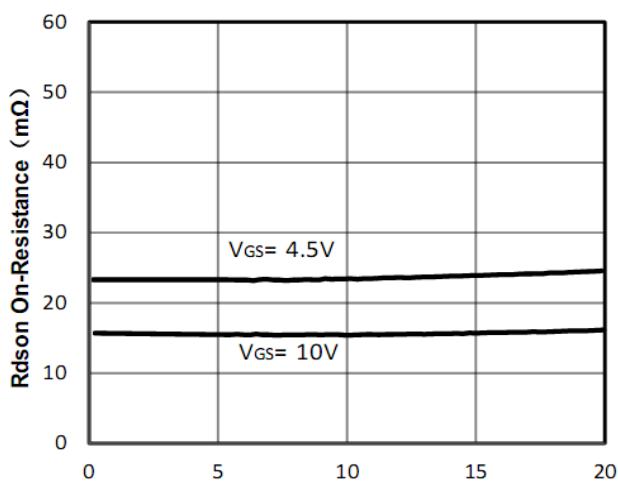
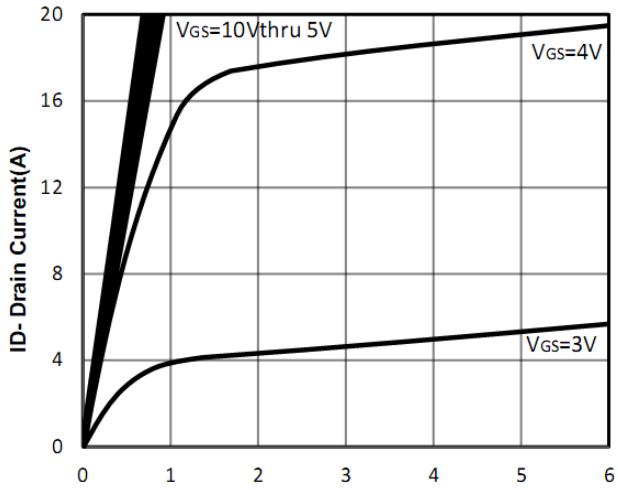
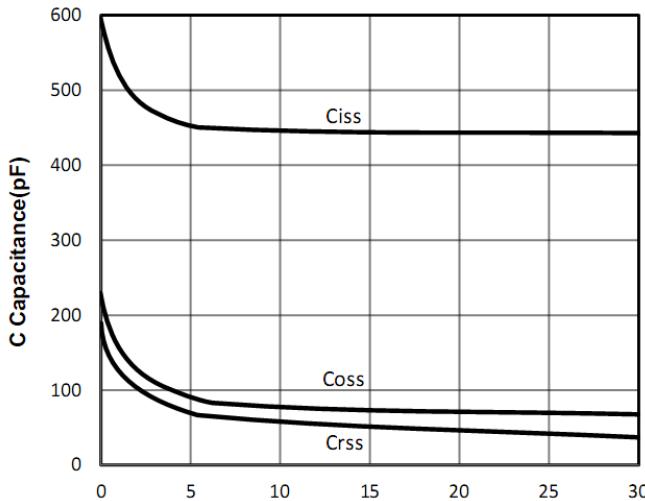
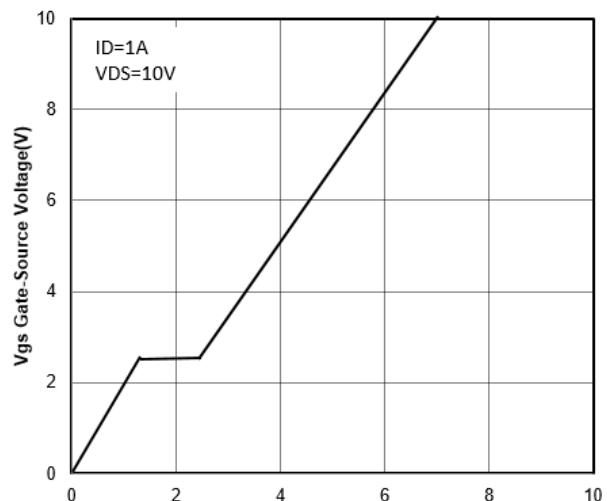
Complementary High Density Trench MOSFET

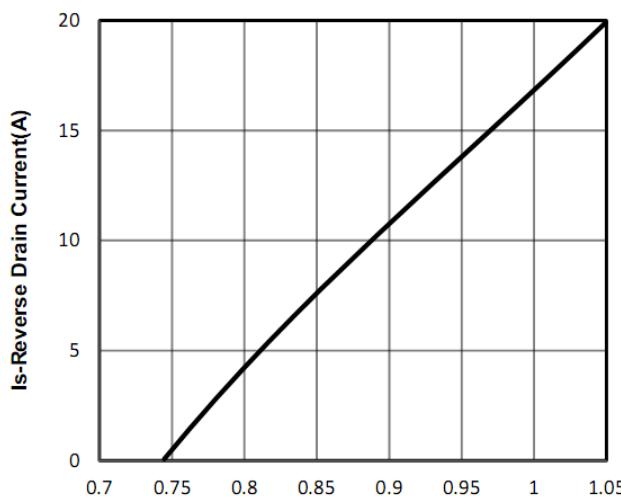
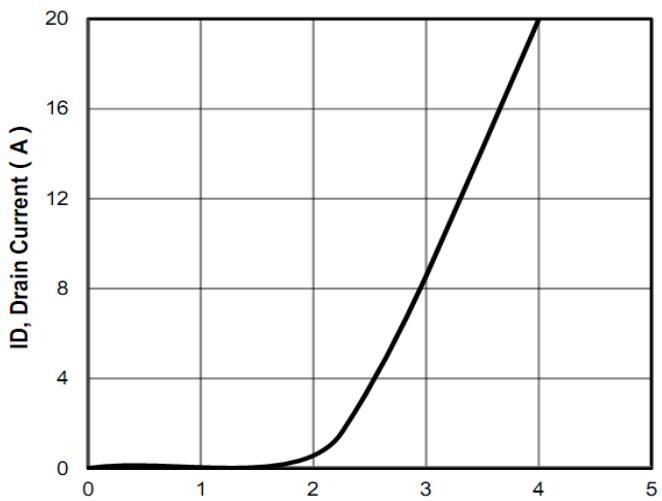
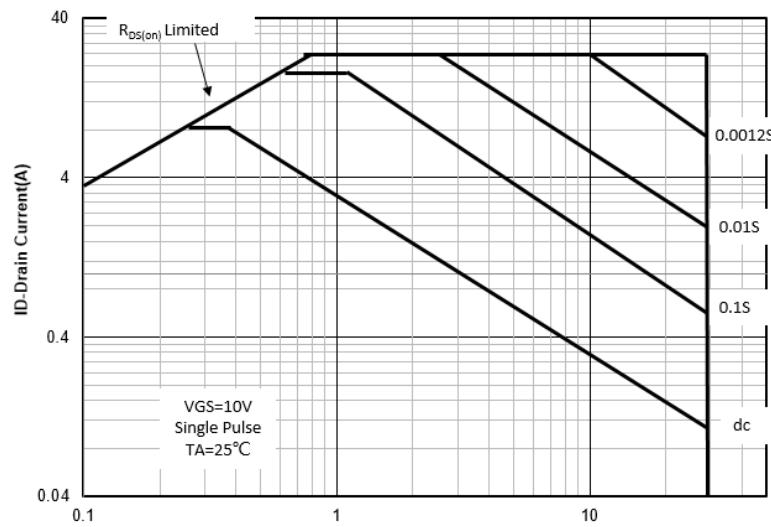
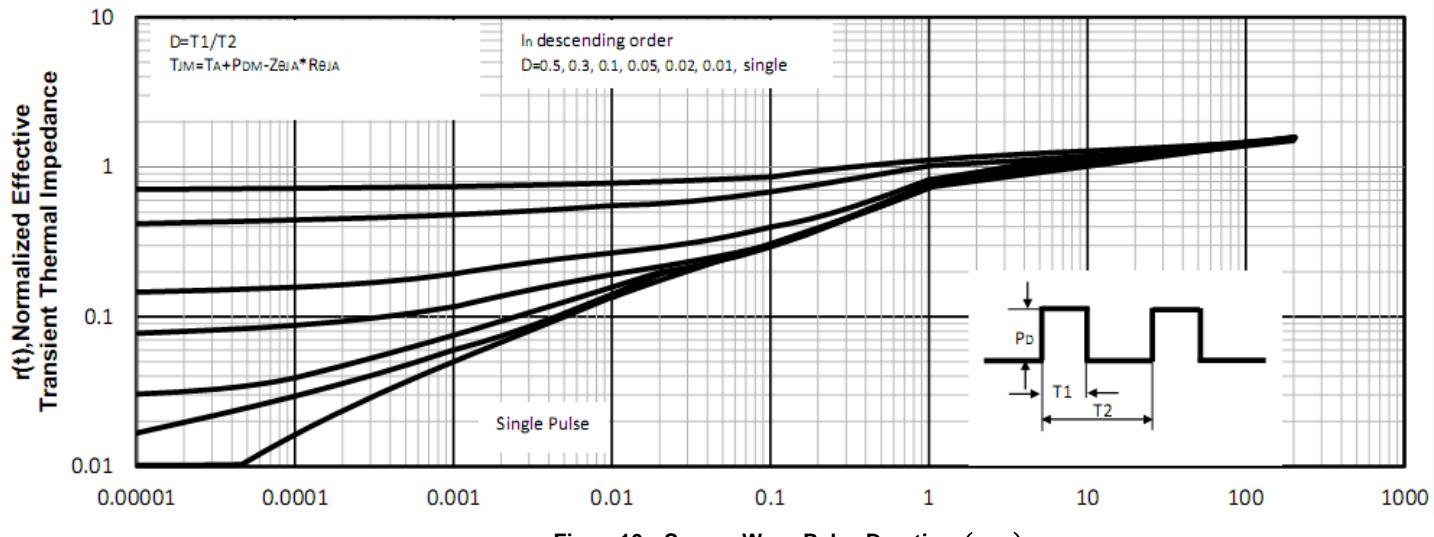
P-Channel Electrical Characteristics

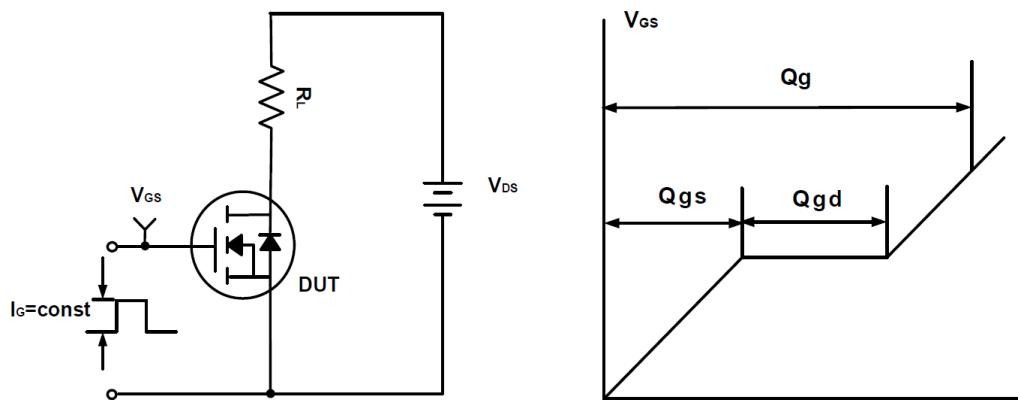
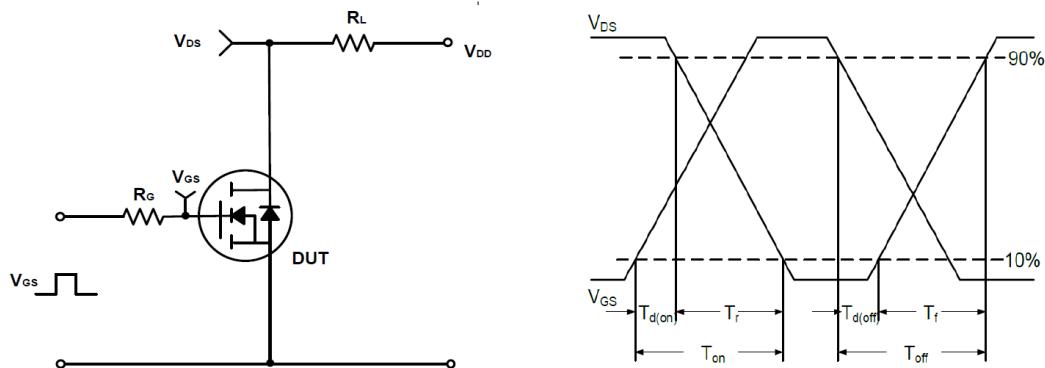
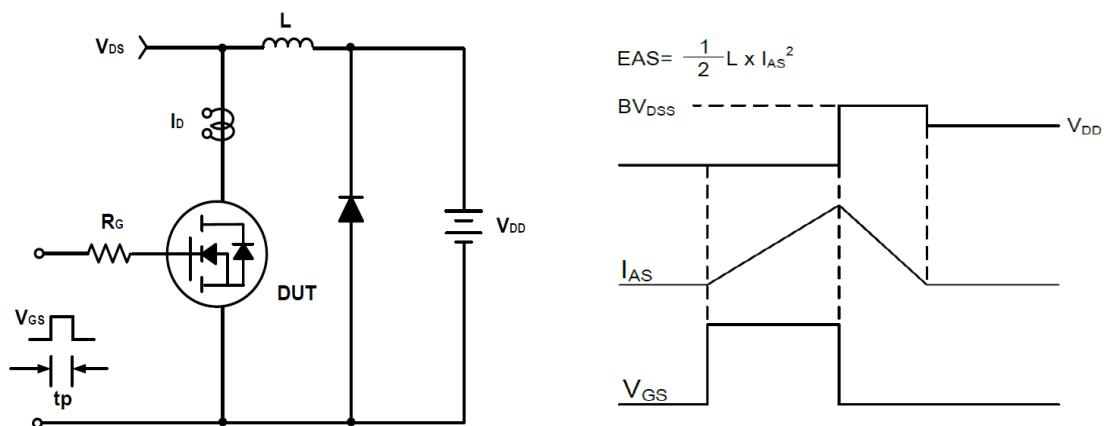
Symbol	Parameter	Condition	Min.	Typ.	Max.	Unit
Static Electrical Characteristics @ TJ = 25°C (unless otherwise stated)						
$V_{(BR)DSS}$	Drain- Source Breakdown Voltage	$VGS=0V$ $ID=-250\mu A$	-30	--	--	V
I_{DSS}	Zero Gate Voltage Drain current	$VDS=-30V, VGS=0V$	--	--	-1	μA
I_{GSS}	Gate-Body Leakage Current	$VGS=\pm 20V, VDS=0V$	--	--	± 100	nA
$V_{GS(TH)}$	Gate Threshold Voltage	$VDS=VGS, ID=-250\mu A$	-1	-1.5	-3	V
$R_{DS(ON)}$	Drain-Source On-State Resistance (Note3)	$VGS=-10V, ID=-6.5A$	--	25	34	$m\Omega$
		$VGS=-4.5V, ID=-5A$	--	37	56	$m\Omega$
g_{FS}	Forward Transconductance	$VDS=-10V, ID=-6A$	--	12.7	--	S
Dynamic Electrical Characteristics @ TJ = 25°C (unless otherwise stated) (Note4)						
C_{iss}	Input Capacitance	$VDS= -15V,$ $VGS=0V,$ $F=1MHz$	--	1320	--	pF
C_{oss}	Output Capacitance		--	651	--	pF
C_{rss}	Reverse Transfer Capacitance		--	448	--	pF
Q_g	Total Gate Charge	$VDS= -15V,$ $ID= -3A,$ $VGS= -10V$	--	20	--	nC
Q_{gs}	Gate-Source Charge		--	4.1	--	nC
Q_{gd}	Gate-Drain Charge		--	2.6	--	nC
Switching Characteristics (Note4)						
$t_{d(on)}$	Turn-on Delay Time	$VDD= -15V,$ $RL=5\Omega,$ $ID= -3A, VGEN= -10V,$ $RG=6\Omega$	--	9.5	--	nS
t_r	Turn-on Rise Time		--	5.4	--	nS
$t_{d(off)}$	Turn-off Delay Time		--	42.5	--	nS
t_f	Turn-off Fall Time		--	13.6	--	nS
Source- Drain Diode Characteristics@ TJ = 25°C (unless otherwise stated)						
V_{SD}	Forward on voltage (Note3)	$IS= -1A, VGS=0V$	--	--	-1	V

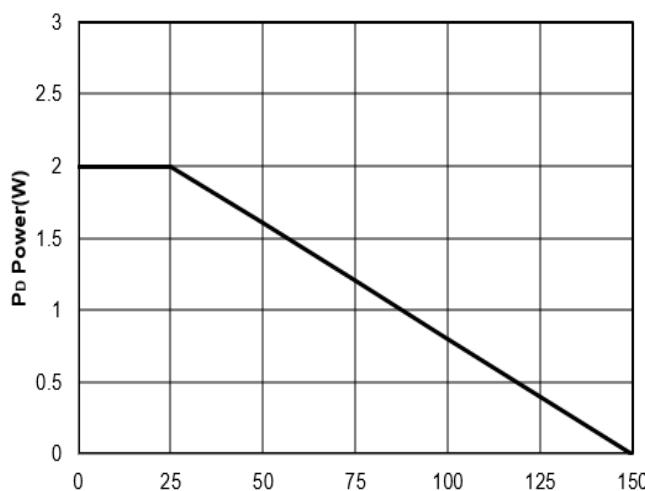
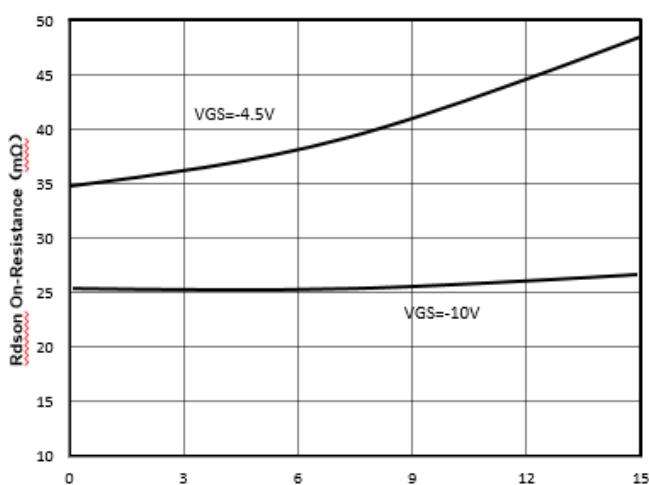
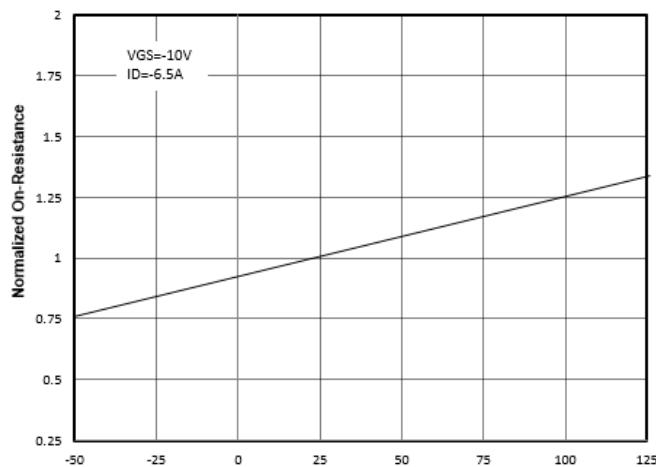
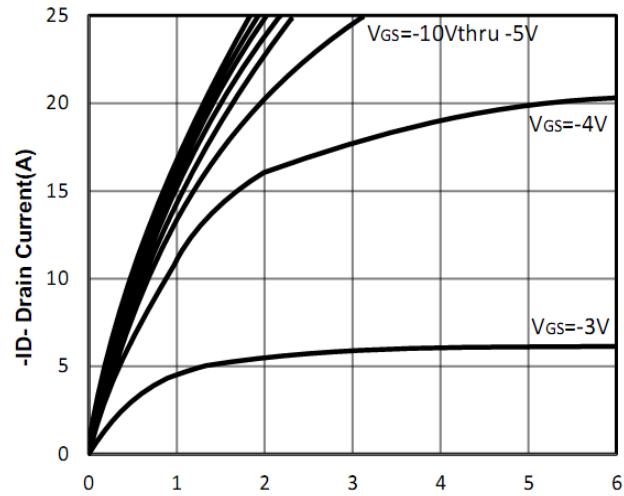
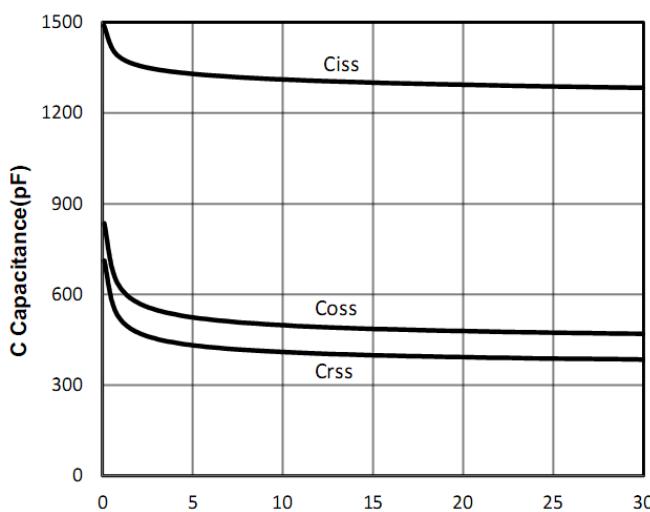
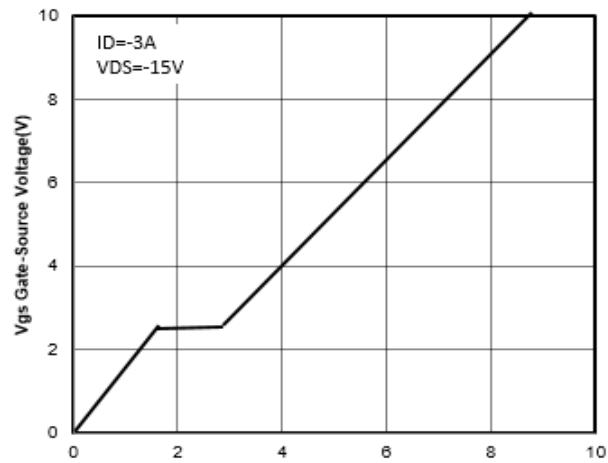
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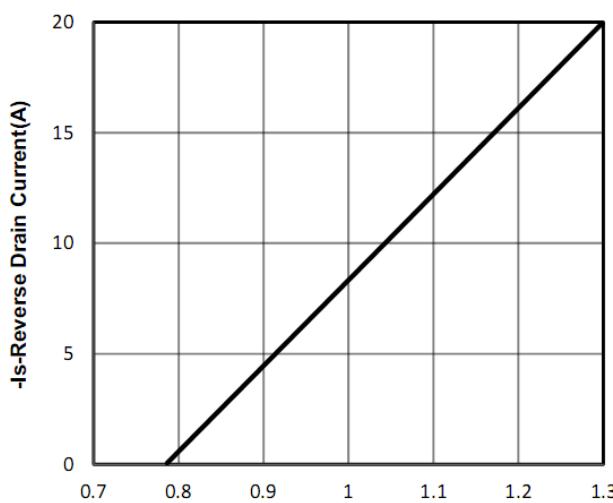
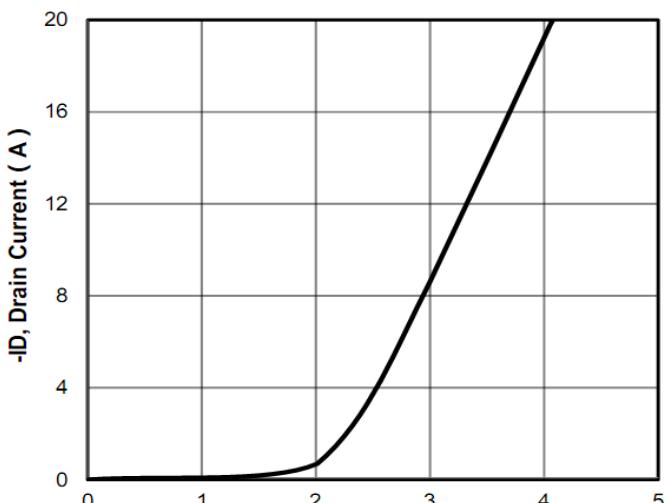
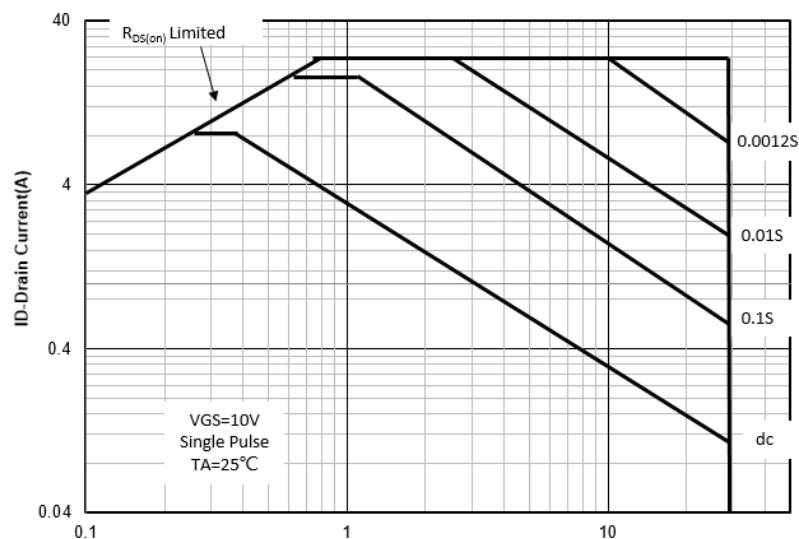
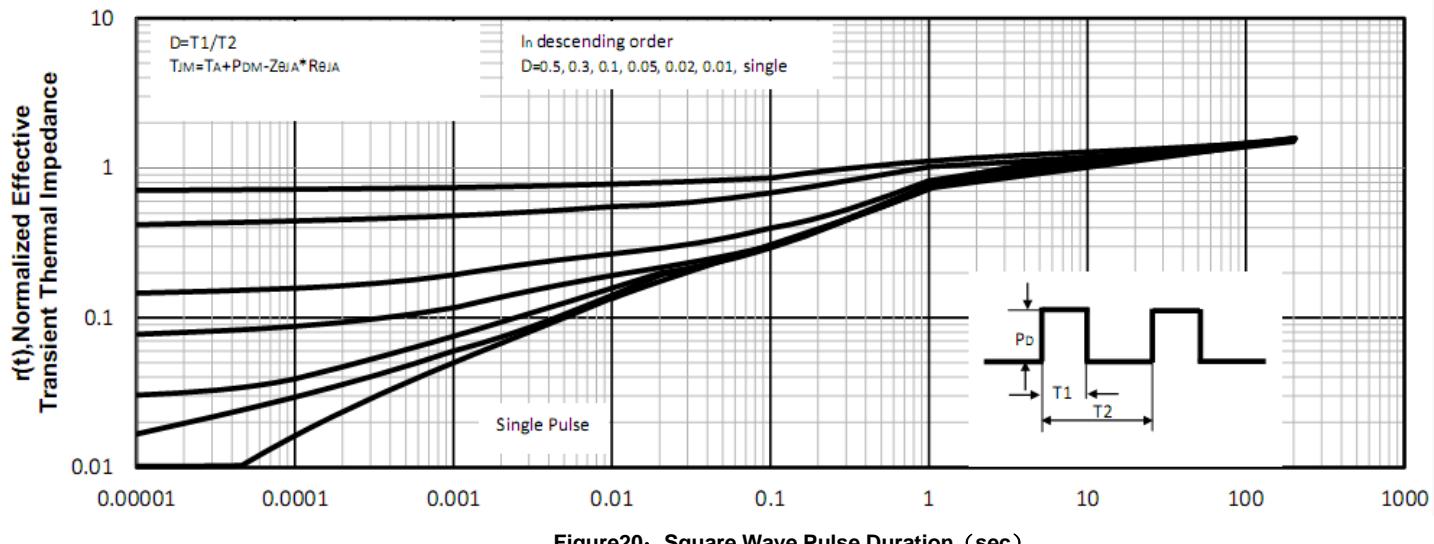
1. Repetitive Rating: Pulse width limited by maximum junction temperature.
2. Surface Mounted on FR4 Board, $t \leq 10$ sec
3. Pulse Test: pulse width ≤ 300 us, duty cycle $\leq 2\%$.
4. Guaranteed by design, not subject to production testing.

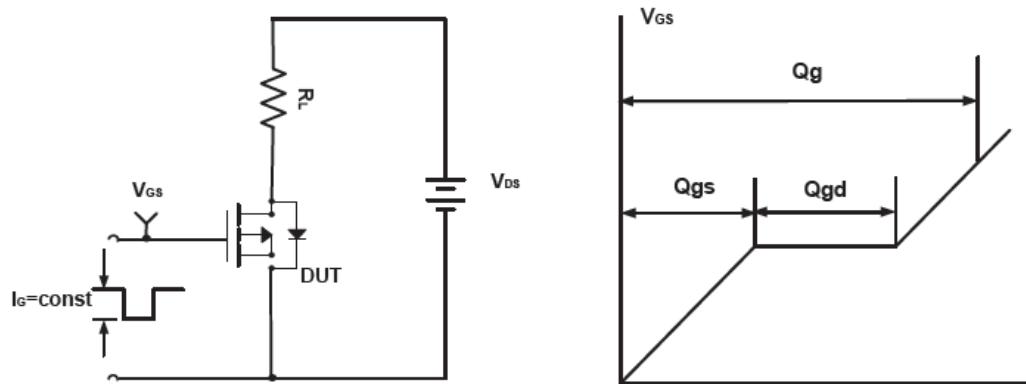
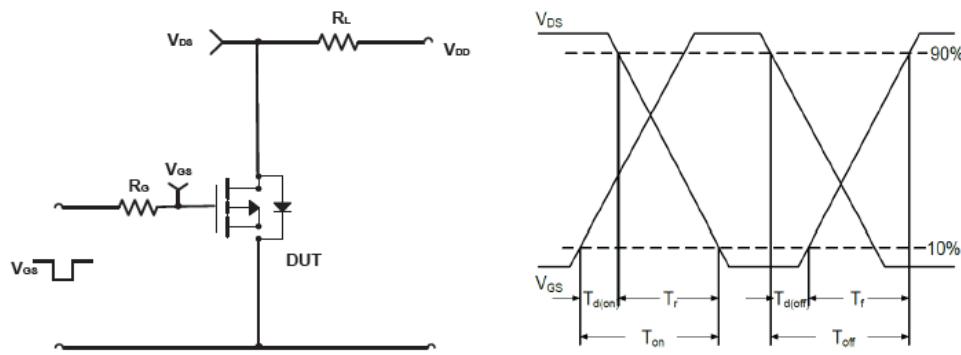
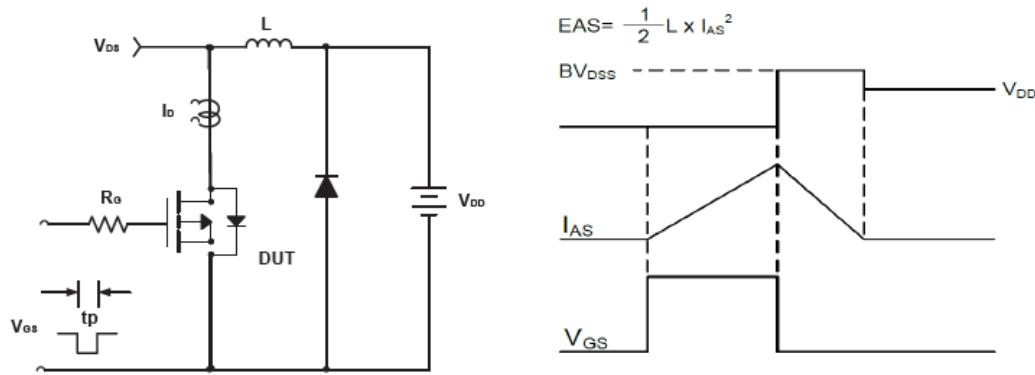
Complementary High Density Trench MOSFET
Typical Characteristics(N-Channel)

Figure1: TJ Junction Temperature (°C)

Figure3: TJ Junction Temperature (°C)

Figure2: ID Drain Current (A)

Figure4: VDS Drain-Source Voltage (V)

Figure5: VDS Drain-Source Voltage (V)

Figure6: Qg Gate Charge (nC)

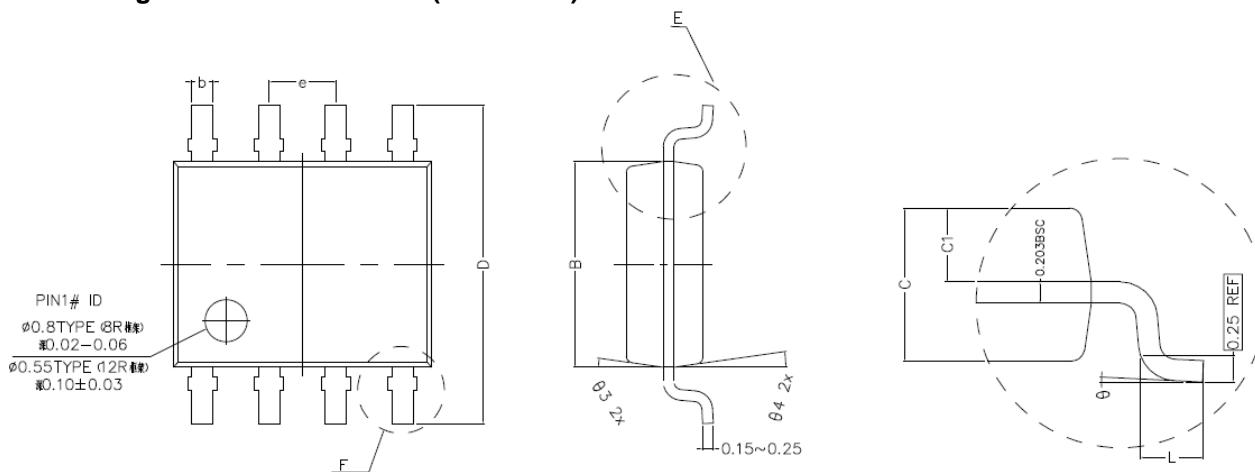
Complementary High Density Trench MOSFET

Figure7: Vsd Source-Drain Voltage (V)

Figure8: Vgs Gate-Source Voltage (V)

Figure9: Vds Drain -Source Voltage (V)

Figure10: Square Wave Pulse Duration (sec)

**Complementary High Density Trench MOSFET
Test Circuit and Waveform(N-Channel):**

Figure A Gate Charge Test Circuit & Waveforms

Figure B Switching Test Circuit & Waveforms

Figure C Unclamped Inductive Switching Circuit & Waveforms

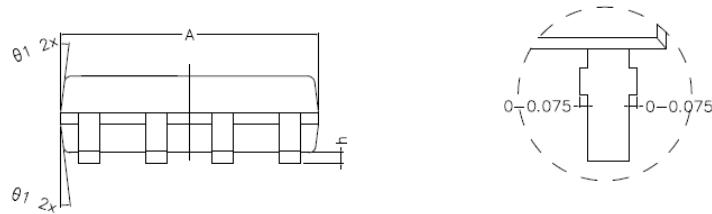
**Complementary High Density Trench MOSFET
Typical Characteristics(P-Channel)**

Figure11: T_j Junction Temperature (°C)

Figure12: -I_D Drain Current (A)

Figure13: T_j Junction Temperature (°C)

Figure14: -V_{DS} Drain-Source Voltage (V)

Figure15: -V_{DS} Drain-Source Voltage (V)

Figure16: Q_g Gate Charge (nC)

Complementary High Density Trench MOSFET

Figure17: -VsD Source-Drain Voltage (V)

Figure18: -Vgs Gate-Source Voltage (V)

Figure19: -Vds Drain-Source Voltage (V)

Figure20: Square Wave Pulse Duration (sec)

Complementary High Density Trench MOSFET
Test Circuit and Waveform(P-Channel):

Figure D Gate Charge Test Circuit & Waveforms

FigureE Switching Test Circuit & Waveforms

Figure F Unclamped Inductive Switching Circuit & Waveforms

Complementary High Density Trench MOSFET
SOP-8 Package Outline Dimensions (Units: mm)


DETAIL E



DETAIL F

COMMON DIMENSIONS (UNITS OF MEASURE IS mm)			
	MIN	NORMAL	MAX
A	4.800	4.900	5.000
B	3.800	3.900	4.000
C	1.350	1.450	1.550
C1	0.650	0.700	0.750
D	5.900	6.100	6.300
L	0.500	0.600	0.700
b	0.350	0.400	0.450
h	0.050	0.150	0.250
e	1.270 TYPE		
θ ₁	7° TYPE(8R)	12° TYPE(12R)	
θ ₂	7° TYPE(8R)	10° TYPE(12R)	
θ ₃	8° TYPE(8R)	12° TYPE(12R)	
θ ₄	8° TYPE(8R)	10° TYPE(12R)	
θ	0° ~ 8°		